

<b>Notice of References Cited</b>	Application/Control No. 10/539,886		Applicant(s)/Patent Under Reexamination EUN ET AL.	
	Examiner SONYA MAZUMDAR		Art Unit 1791	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,568,265	05-2003	Shibue et al.	73/335.05
*	B	US-2004/0072432	04-2004	Yun et al.	438/689
*	C	US-7,136,874	11-2006	Mercer et al.	707/104.1
*	D	US-2006/0042541	03-2006	Eun et al.	117/104
*	E	US-2002/0048076	04-2002	Kondo et al.	359/322
*	F	US-2001/0035123	11-2001	Lee et al.	117/3
*	G	US-5,925,968	07-1999	Yachi et al.	310/320
*	H	US-5,183,593	02-1993	Durand et al.	252/514
*	I	US-3,715,802	02-1973	Suenaga et al.	438/107
*	J	US-4,772,985	09-1988	Yasumoto et al.	361/321.3
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.